

# HID GLOBAL CORPORATION

## MULTICLASS

Model: RP15D-6407-300

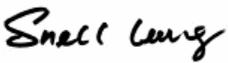
22 October 2008

Report No.: SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
(This report supersedes NONE)



Modifications made to the product : None

This Test Report is Issued Under the Authority of:

	
Snell Leong Test Engineer	Leslie Bai Engineering Reviewer

This test report may be reproduced in full only.  
Test result presented in this test report is applicable to the representative sample only.

# EMC Test Report

To: FCC Part 15.207, 15.209, 15.225, RSS-GEN, RSS-210 & RSS-310

SIEMIC, INC.  
Accessing global markets



**SIEMIC ACREDITATION DETAILS: NVLAP Lab Code: 200729-0**

**United States Department of Commerce  
National Institute of Standards and Technology**

**NVLAP<sup>®</sup>**

---

**Certificate of Accreditation to ISO/IEC 17025:2005**

---

**NVLAP LAB CODE: 200729-0**

**SIEMIC Laboratories**  
San Jose, CA

*is accredited by the National Voluntary Laboratory Accreditation Program for specific services,  
listed on the Scope of Accreditation, for:*

**ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS**

*This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005.  
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality  
management system (refer to joint ISO-ILAC-IAF Communique dated 18 June 2005).*

2008-01-01 through 2008-12-31  
*Effective dates*



*Sally S. Bruce*  
For the National Institute of Standards and Technology

**SIEMIC ACREDITATION DETAILS: A2LA Certificate Number: 2742.01**



**THE AMERICAN ASSOCIATION FOR  
LABORATORY ACCREDITATION**

**ACCREDITED LABORATORY**

A2LA has accredited

**SIEMIC LABORATORIES**  
San Jose, CA

for technical competence in the field of

**Electrical Testing**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General Requirements for the Competence of Testing and Calibration Laboratories*. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-LAF Communiqué dated 18 June 2005*).



Presented this 11th day of July 2008.



President  
For the Accreditation Council  
Certificate Number 2742.01  
Valid to September 30, 2010

For the tests or types of tests to which this accreditation applies,  
please refer to the laboratory's Electrical Scope of Accreditation.

**SIEMIC ACREDITATION DETAILS: FCC Registration No. 783147**

**FEDERAL COMMUNICATIONS COMMISSION**

**Laboratory Division  
7435 Oakland Mills Road  
Columbia, MD 21046**

December 20, 2007

Registration Number: 783147

SIEMIC Laboratories  
2206 Ringwood Avenue,  
San Jose, CA 95131

Attention: Leslie Bai

Re: Measurement facility located at San Jose  
3 & 10 meter site  
Date of Renewal: December 20, 2007

Dear Sir or Madam:

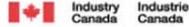
Your request for renewal of the registration of the subject measurement facility has been received. The information submitted has been placed in your file and the registration has been renewed. The name of your organization will remain on the list of facilities whose measurement data will be accepted in conjunction with applications for Certification under Parts 15 or 18 of the Commission's Rules. Please note that the file must be updated for any changes made to the facility and the registration must be renewed at least every three years.

Measurement facilities that have indicated that they are available to the public to perform measurement services on a fee basis may be found on the FCC website [www.fcc.gov](http://www.fcc.gov) under E-Filing, OET Equipment Authorization Electronic Filing, Test Firms.

Sincerely,

Phyllis Parrish  
Industry Analyst

**SIEMIC ACREDITATION DETAILS: Industry of Canada Registration No. 4842-1**



May 23rd, 2008

OUR FILE: 46405-4842  
 Submission No: 126429

Siemic Inc.  
 2206 Ringwood Ave.  
 San Jose CA 95131  
 USA

*Attention:* Leslie Bai

Dear Sir/Madame:

The Bureau has received your application for the registration / renewal of a 3/10m OATS. Be advised that the information received was satisfactory to Industry Canada. The following number(s) is now associated to the site(s) for which registration / renewal was sought (**4842A-1**). Please reference the appropriate site number in the body of test reports containing measurements performed on the site. In addition, please be informed that the Bureau is now utilizing a **new site numbering scheme** in order to simplify the electronic filing process. Our goal is to reduce the number of secondary codes associated to one particular company. The following changes have been made to your record.

- Your primary code is: **4842**
- The company number associated to the site(s) located at the above address is: **4842A**
- The table below is a summary of the changes made to the unique site registration number(s):

New Site Number	Obsolete Site Number	Description of Site	Expiry Date (YYYY-MM-DD)
4842A-1	4842-1	3m Chamber	2010-05-23

Furthermore, to obtain or renew a unique site number, the applicant shall demonstrate that the site has been accredited to ANSI C63.4-2003 or later. A scope of accreditation indicating the accreditation by a recognized accreditation body to ANSI C63.4-2003 shall be accepted. Please indicate in a letter the previous assigned site number if applicable and the type of site (example: 3 meter OATS or 3 meter chamber). If the test facility is not accredited to ANSI C63.4-2003 or later, the test facility shall submit test data demonstrating full compliance with the ANSI standard. The Bureau will evaluate the filing to determine if recognition shall be granted.

The frequency for re-validation of the test site and the information that is required to be filed or retained by the testing party shall comply with the requirements established by the accrediting organization. However, in all cases, test site re-validation shall occur on an interval not to exceed two years. There is no fee or form associated with an OATS filing. OATS submissions are encouraged to be submitted electronically to the Bureau using the following URL:  
[http://strategis.ic.gc.ca/epic/internet/inceb-bhst.nsf/en/h\\_tt00052e.html](http://strategis.ic.gc.ca/epic/internet/inceb-bhst.nsf/en/h_tt00052e.html).

If you have any questions, you may contact the Bureau by e-mail at [certification.bureau@ic.gc.ca](mailto:certification.bureau@ic.gc.ca)  
 Please reference our file and submission number above for all correspondence.

Yours sincerely,



S. Proulx  
 Test & Measurement Specialist  
 Certification and Engineering Bureau  
 3701 Carling Ave., Building 94  
 Ottawa, Ontario K2H 8S2



**SIEMIC, Inc.**  
Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To: FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 6 of 53  
www.siemec.com

**SIEMIC ACREDITATION DETAILS: Japan VCCI Registration No. 2195**



Voluntary Control Council for Interference  
by Information Technology Equipment  
7F NOA Bldg. 2-3-5, Azabudai,  
Minato-Ku, Tokyo, Japan, 108-0041  
Tel:+81-3-5575-3138  
Fax:+81-3-5575-3137  
<http://www.vccior.jp>

February 12, 2004

**TO: SIEMIC, INC.**

**Membership NO: 2195**

We confirmed your payment for annual membership fee and admission fee. Thank you very much for your remitting.

Please find enclosed VCCI documents. As admission fee and annual membership fee were confirmed, your company registered as VCCI official member.

From now on, it is possible for your company to submit conformity verification report or/and application for registration of measurement facilities.

Please find necessary forms for your submission from VCCI web-site.  
[www.vccior.jp](http://www.vccior.jp)

When you submit conformity verification report, please submit to Ms. Yoko Inagaki / [inagaki@vccior.jp](mailto:inagaki@vccior.jp) and application for registration of measurement facilities, please submit to Mr. Masaru Denda / [denda@vccior.jp](mailto:denda@vccior.jp)

Their address, phone and fax number are absolutely same as I. Please refer address indicated on top right-hand corner of this page.

If you have any other questions regarding membership, feel free to contact me. Thank you very much.

Best Regards,

Naoko Hori (Ms.)  
VCCI  
[hori@vccior.jp](mailto:hori@vccior.jp)

Enclosure



**SIEMIC, Inc.**  
Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 7 of 53  
www.siemic.com

**SIEMIC ACREDITATION DETAILS: Japan RF Technologies Accreditation No. MRF050927**

**RFT**

## Certificate

This is to certify that the  
Quality Management System  
of

**SIEMIC , Inc.**  
2206 Ringwood Avenue  
San Jose, California 95131 U.S.A

has been authorized to carry out Japan Specified Radio Equipment test by  
order and under supervision of RF Technologies Co., Ltd. according to  
Notification No.88 of Radio Law.

An assessment of the laboratory was conducted according to the "Procedure and  
Conditions for Appointments of 2.4GHz Band Low power data communications system  
that Bluetooth and Wireless LAN test with reference to ISO/IEC 17025  
by an RF Technologies Co., Ltd. auditor.

**Audit Report No. MRF050927**

 Kazuyuki Sarashina Auditor RF Technologies Co., Ltd.	 Toshihiro Ikegami President RF Technologies Co., Ltd.
Audit Date September 27th, 2005	Issued Date October 5th, 2005

This Certificate is valid until **September 26<sup>th</sup> 2006 or next schedule audit.**

No:006 Registered Certification Body  
RF Technologies Co., Ltd.  
472, Nippa-cho, Kohoku-ku, Yokohama, 223-0057, Japan





**SIEMIC, Inc.**  
Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To: FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 8 of 53  
www.siemic.com

**SIEMIC ACREDITATION DETAILS: Korea MIC Lab Code: KR0032**

# 시험기관지정서

## Certificate

of Designated Testing Laboratory

지정번호(No.) : KR0032

시험기관명 : (주)현대교정인증기술원  
(Name of Lab.) (Hyundai Calibration & Certification Technologies Co., Ltd)

주 소 : 경기도 이천시 부발읍 아미리 산136-1  
(Address) (136-1, Ami-ri, Bubal-eup, Icheon-si, Kyunggi-Do, Korea)  
2206 Ringwood Avenue San Jose, CA, USA.

시험분야 및 범위 : 유선(Telecommunication Part)  
(Area & Category) 무선(Radio Communication Part)  
전자파장해(EMD) : 미국지사 포함  
전자파내성(EMS) : 미국지사 포함  
전기안전(Safety)  
전자파흡수율(SAR)

위 기관을 정보통신기기시험기관지정및관리등에관한규칙에  
의해 정보통신기기시험기관으로 지정합니다.

*This is to certify that  
the above mentioned laboratory is designated  
as the testing laboratory in accordance with  
the Regulations on Designation of Testing Laboratory  
for Information and Communication Equipment.*

2005년(Year) 7월(Month) 5일(Date)

**전 파 연구 소 장**  
Director General of Radio Research Laboratory  
Ministry of Information and Communication  
Republic of Korea





**SIEMIC, Inc.**

Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To: FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 9 of 53  
www.siemic.com

**SIEMIC ACREDITATION DETAILS: Korea CAB ID: US0160**



**UNITED STATES DEPARTMENT OF COMMERCE**  
National Institute of Standards and Technology  
Gaithersburg, Maryland 20899

April 17, 2006

Mr. Leslie Bai  
SIEMIC Laboratories  
2206 Ringwood Avenue  
San Jose, CA 95131

Dear Mr. Bai:

I am pleased to inform you that your laboratory has been recognized by the Ministry of Information and Communication's Radio Research Laboratory (RRL) under the Asia Pacific Economic Cooperation (APEC) Mutual Recognition Arrangement (MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name: **SIEMIC Laboratories**  
Identification No.: **US0160**  
Scope:

Coverage	Standards	Date of Recognition
Electro Magnetic Interference	1. RRL Notice No. 2005-82: Technical Requirements for Electromagnetic Interference 2. Annex 8(KN-22), RRL Notice No. 2005-131: Conformity Assessment Procedure for Electromagnetic Interference	April 13, 2006
Electro Magnetic Susceptibility	1. RRL Notice No. 2005-130: Technical Requirements for Electromagnetic Susceptibility 2. Annex 1-7(KN-61000-4-2, -4-3, -4-4, -4-5, -4-6, -4-8, -4-11), RRL Notice No. 2005-132: Conformity Assessment Procedure for Electromagnetic Susceptibility	April 13, 2006

You may submit test data to RRL to verify that the equipment to be imported into Korea satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

The names of all recognized CABs will be posted on the NIST website at <http://ts.nist.gov/mra>. If you have any questions please contact Mr. Jogindar (Joe) Dhillon at (301) 975-5521. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

David F. Alderman  
Group Leader, Standards Coordination and Conformity Group

cc: Jogindar Dhillon





**SIEMIC, Inc.**

Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To: FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 10 of 53  
www.siemec.com

**SIEMIC ACREDITATION DETAILS: Taiwan BSMI Accreditation No. SL2-IN-E-1130R**



**UNITED STATES DEPARTMENT OF COMMERCE**  
National Institute of Standards and Technology  
Gaithersburg, Maryland 20899

May 3, 2006

Mr. Leslie Bai  
SIEMIC Laboratories  
2206 Ringwood Avenue  
San Jose, CA 95131

Dear Mr. Bai:

I am pleased to inform you that your laboratory has been recognized by the Chinese Taipei's Bureau of Standards, Metrology, and Inspection (BSMI) under the Asia Pacific Economic Cooperation (APEC) Mutual Recognition Arrangement (MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. You may submit test data to BSMI to verify that the equipment to be imported into Chinese Taipei satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements. The pertinent designation information is as follows:

- BSMI number: **SL2-IN-E-1130R** (Must be applied to the test reports)
- U.S Identification No: **US0160**
- Scope of Designation: **CNS 13438**
- Authorized signatory: **Mr. Leslie Bai**

The names of all recognized CABs will be posted on the NIST website at <http://ts.nist.gov/mra>. If you have any questions, please contact Mr. Dhillon at 301-975-5521. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

David F. Alderman  
Group Leader, Standards Coordination and Conformity Group

cc: Jogindar Dhillon

**NIST**



**SIEMIC, Inc.**  
Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To: FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 11 of 53  
www.siemec.com

**SIEMIC ACREDITATION DETAILS: Taiwan NCC CAB ID: US0160**



**UNITED STATES DEPARTMENT OF COMMERCE**  
**National Institute of Standards and Technology**  
Gaithersburg, Maryland 20899

August 8, 2006

Mr. Leslie Bai  
SIEMIC Laboratories  
2206 Ringwood Avenue  
San Jose, CA 95131

Dear Mr. Bai:

I am pleased to inform you that SIEMIC Laboratories has been recognized by the Chinese Taipei's National Communications Commission (NCC) under the Asia Pacific Economic Cooperation for Telecommunications and Information, Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA.

You may submit test data to NCC to verify that the equipment to be imported into Chinese Taipei satisfies their applicable requirements using the following guidelines:

- Your laboratory's assigned 6-digit U.S. identification number is **US0160**. You should reference this number in your correspondence.
- The scope of designation is limited to **LP0002**. Your designation will remain in force as long as your accreditation remains valid for the scope of designation.

If you have any questions please contact Mr. Jogindar Dhillon via email at [dhillon@nist.gov](mailto:dhillon@nist.gov) or via fax at 301-975-5414. The names of all recognized laboratories will be posted on the NIST website at <http://ts.nist.gov/mra>. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

David F. Alderman  
Group Leader, Standards Coordination and Conformity Group

cc: Jogindar Dhillon

**NIST**



**SIEMIC, Inc.**

Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To: FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 12 of 53  
www.siemic.com

## SIEMIC ACREDITATION DETAILS: Mexico NOM Recognition



CAMARA NACIONAL  
DE LA INDUSTRIA  
ELECTRONICA, DE  
TELECOMUNICACIONES  
E INFORMÁTICA

### Laboratorio Valentín V. Rivero

México D.F. a 18 de octubre de 2006.

**LESLIE BAI  
DIRECTOR OF CERTIFICATION  
SIEMIC LABORATORIES, INC.  
ACCESSING GLOBAL MARKETS  
P R E S E N T E**

En contestación a su escrito de fecha 5 de septiembre del año en curso, le comento que estamos muy interesados en su intención de firmar un Acuerdo de Reconocimiento Mutuo, para lo cual adjunto a este escrito encontrara el Acuerdo en idioma inglés y español preferido de los cuales le pido sea revisado y en su caso corregido, para que si esta de acuerdo poder firmarlo para mandarlo con las autoridades Mexicanas para su visto bueno y así poder ejercer dicho acuerdo.

Aprovecho este escrito para mencionarle que nuestro intermediario gestor será la empresa Isabel de México, S. A. de C. V., empresa que ha colaborado durante mucho tiempo con nosotros en lo relacionado a la evaluación de la conformidad y que cuenta con amplia experiencia en la gestoría de la certificación de cumplimiento con Normas Oficiales Mexicanas de producto en México.

Me despido de usted enviándole un cordial saludo y esperando sus comentarios al Acuerdo que nos ocupa.

Atentamente:



**Ing. Faustino B. González  
Gerente Técnico del Laboratorio de  
CANIETI.**

Callejón T1  
Hidrovez Condésa  
06100 México, D.F.  
Tel. 5264-0908 con 12 líneas  
Fax 5264-0498  
www.canieti.org



**SIEMIC, Inc.**

Accessing global markets

Title: RF Test Report of HID Global Corporation  
Model : RP15D-6407-300  
To: FCC 15.225 2008, RSS-210 Issue 7 : 2007

Serial# SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)  
Issue Date 22 October 2008  
Page 13 of 53  
www.siemec.com

**SIEMIC ACREDITATION DETAILS: Hong Kong OFTA Recognition No. D23/16V**



Your Ref 來函編號 : D23/16 V  
Our Ref 本局編號 :

Telephone 電話 : (852) 2961 6320  
Fax No 圖文傳真 : (852) 2838 5004  
E-mail 電郵地址 : 20 July 2005

Mr. Leslie Bai  
Director of Certification,  
SIEMIC Laboratories  
2206 Ringwood Avenue  
San Jose, California 95131  
USA

Dear Mr. Bai,

**Application of Recognised Testing Agency (RTA)**

Referring your submission of 28 June 2005 in relation to the application of RTA, I am pleased to inform you that OFTA has appointed SIEMIC Laboratories (SIEMIC) as a Recognised Testing Agency (RTA) :

Please note that, under the Hong Kong Telecommunications Equipment Evaluation and Certification (HKTEC) Scheme, SIEMIC is authorized to conduct evaluation tests on telecommunications equipment against the following HKTA specifications :

Scope of recognition (HKTA Specifications) :

1001, 1002, 1004, 1006, 1007, 1008  
1010, 1015, 1016  
1022, 1026, 1027, 1029  
1030, 1031, 1032, 1033, 1034, 1035, 1039  
1041, 1042, 1043, 1045, 1047, 1048  
2001

You are requested to refer to and comply with the code of practice and guidelines for RTA as given in the Information Note OFTA I 411 "Recognised Testing Agency (RTA) for Conducting Evaluation Test of Telecommunications Equipment", which can be downloaded from OFTA's homepage at <http://www.ofta.gov.hk/tec/information-notes.html>.

If you have any queries, please do not hesitate to contact me.

Yours sincerely,

(K K Sin)  
for Director-General  
of Telecommunications

Office of the Telecommunications Authority  
29/F Wu Chung House 213 Queen's Road East Wan Chai Hong Kong  
電訊管理局  
香港灣仔皇后大道東 213 號胡忠大廈 29 字樓

<http://www.ofta.gov.hk>

This page has been left blank intentionally.

# CONTENTS

1	EXECUTIVE SUMMARY & EUT INFORMATION .....	17
2	TECHNICAL DETAILS.....	18
3	MODIFICATION.....	19
4	TEST SUMMARY.....	20
5	MEASUREMENTS, EXAMINATION AND DERIVED RESULTS .....	21
	ANNEX A. TEST INSTRUMENT & METHOD .....	33
	ANNEX B. TEST SETUP PHOTOGRAPHS.....	37
	ANNEX B. I. EUT INTERNAL PHOTOGRAPHS .....	41
	ANNEX B. II. EUT EXTERNAL PHOTOGRAPHS .....	46
	ANNEX D USER MANUAL, BLOCK & CIRCUIT DIAGRAM .....	53

This page has been left blank intentionally.

# 1 Executive Summary & EUT information

The purpose of this test programmed was to demonstrate compliance of the HID Global Corp., Model: RP15D-6407-300 against the current Stipulated Standards. The MultiCLASS Indala have demonstrated compliance with the FCC 15.207, 15.209, 15.225: 2008 and Canadian Standards RS-Gen Issue 2, RSS-210 issue 7 & RSS 310 issue 2.

HID Global Corp. is the applicant and claimed manufacturer of this tested product. For the detailed description of this product, please refer to the iCLASS User Manual submitted as another Exhibit to this application.

The equipment under test radio operating frequency is 125 kHz and 13.56 MHz.

The test has demonstrated that this unit complies with stipulated standards.

## EUT Information

<b>EUT Description</b>	:	The HID RP15D-6407-300 is an inductive proximity card reader intended to be used in access control systems, parking systems and other applications using RFID readers. It is capable of reading 125 kHz and 13.56 MHz inductive tags.
<b>Model No</b>	:	RP15D-6407-300
<b>Serial No</b>	:	N/A
<b>Input Power</b>	:	12 VDC
<b>Classification Per Stipulated Test Standard</b>	:	RFID Reader

## 2 TECHNICAL DETAILS

Purpose	Compliance testing of MultiCLASS with stipulated standard
Applicant / Client	HID Global Corporation
Manufacturer	HID Global Corporation 15730 Barranca Parkway Irvine, CA 92618 USA
Laboratory performing the tests	SIEMIC Laboratories
Test report reference number	SL08080401-HID-014-RP15D-6407-300 (15.225 & RSS-210)
Date EUT received	19 September 2008
Standard applied	47 CFR §15.207, 15.209, 15.255: 2008 & Canadian Standards RS-GEN Issue 2: 2007, RSS-210 Issue 7: 2007 & RSS-310 Issue 2: 2007
Dates of test (from – to)	23 September – 03 October 2008
No of Units:	1
Equipment Category:	DXX & DCD
Trade Name:	MultiCLASS
Model :	RP15D-6407-300
RF Operating Frequency (ies)	125 kHz and 13.56 MHz (RFID)
Number of Channels :	125 kHz (1) & 13.56 MHz (1)
Modulation :	125 kHz (PSK) & 13.56 MHz (AM)
FCC ID :	JQ6-MCLASS15D
IC ID :	2236B-ICLASS

### 3 MODIFICATION

**NONE**

## 4 TEST SUMMARY

The product was tested in accordance with the following specifications. All testing has been performed according to below product classification:

**RFID Reader**

**Test Results Summary**

Test Standard		Description	Pass / Fail
47 CFR Part 15.225: 2008	RSS 210 Issue 7: 2007 & RSS-310 Issue 2: 2007		
15.203		Antenna Requirement	Pass
15.207(a)	RSS Gen(7.2.2)	Conducted Emissions Voltage	Pass
15.225(a)	RSS210(A2.6)	Limit in the band of 13.553 – 13.567 MHz	Pass
15.225(b)	RSS210(A2.6)	Limit in the band of 13.410 – 13.553 MHz and 13.567 – 13.710 MHz	Pass
15.225(c)	RSS210(A2.6)	Limit in the band of 13.110 – 13.410 MHz and 13.710 – 14.010 MHz	Pass
15.225(d), 15.209	RSS210(A2.6)	Limit outside the band of 13.110 – 14.010 MHz	Pass
15.225(e)	RSS210(A2.6)	Frequency Stability	Pass
	RSS-210(5.9.1)	Occupied Bandwidth	Pass
	RSS-310 (3.7)	Very Low Power Devices Operating Below 490 kHz	Pass

ANSI C63.4: 2003/ RSS-Gen Issue 2: 2007

PS: All measurement uncertainties are not taken into consideration for all presented test result.

## 5 MEASUREMENTS, EXAMINATION AND DERIVED RESULTS

### 5.1 Antenna Requirement

**Requirement(s):** 47 CFR §15.203

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Antenna requirement must meet at least one of the following:

- a) Antenna must be permanently attached to the device.
  - b) Antenna must use a unique type of connector to attach to the device.
  - c) Device must be professionally installed. Installer shall be responsible for ensuring that the correct antenna is employed with the device.
- 
- 1) The RFID antenna is integral to the main board permanently to the device which meets the requirement. (See Internal photographs in Annex B.i.)

## 5.2 Conducted Emissions Voltage

**Requirement(s):** 47 CFR §15.207

Requirement:

Frequency of emission (MHz)	Conducted limit (dBµV)	
	Quasi-peak	Average
0.15–0.5	66 to 56*	56 to 46*
0.5–5	56	46
5–30	60	50

\*Decreases with the logarithm of the frequency.

Procedures:

1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR and Average detectors, are reported. All other emissions were relatively insignificant.
2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
3. Conducted Emissions Measurement Uncertainty  
All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 9kHz – 30MHz (Average & Quasi-peak) is ±3.5dB.
4. Environmental Conditions

Temperature	28°C
Relative Humidity	50%
Atmospheric Pressure	1019mbar

Test Date : September 23 – October 03, 2008  
Tested By : Snell Leong

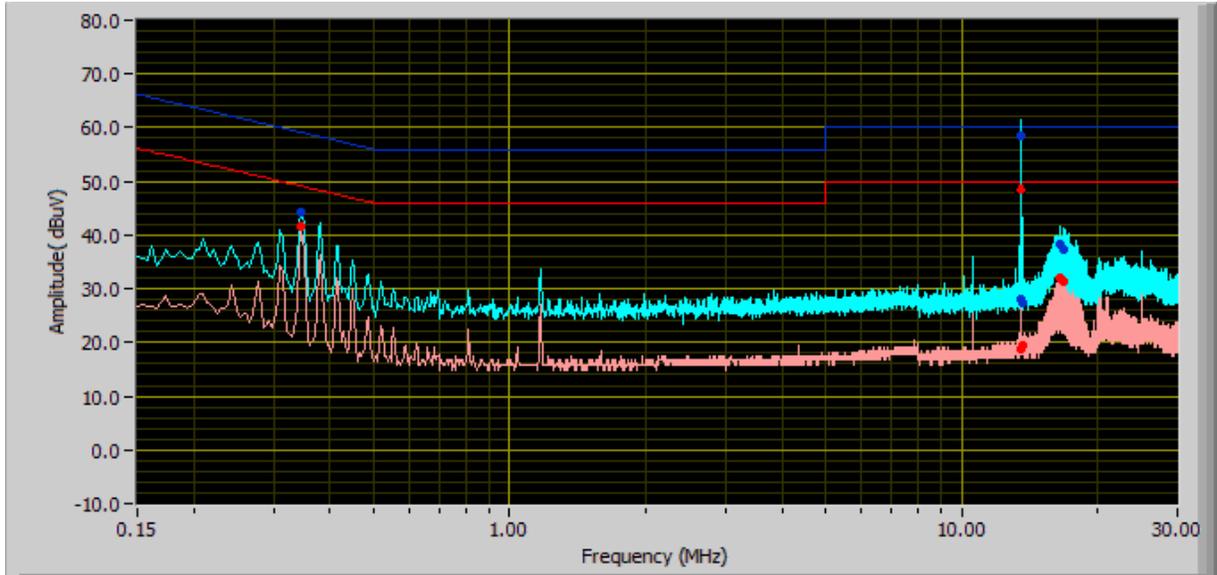
**Results:** Pass

**NOTE:** Applicant Stated that the MultiCLASS Model: RP15N-6407-300 is representative of testing the RP15D-6407-300 because:

- 1) the RP40 models have a larger 13.56MHz Antenna
- 2) the RP40 models have the same 125kHz transmit section and antenna
- 3) the amount of energy coupled to the input of the AC/DC power supply is directly proportional to the B-field antenna size

Given this Model: RP15D-6407-300 was tested as the worst case model without terminating either antenna

**AC Line**

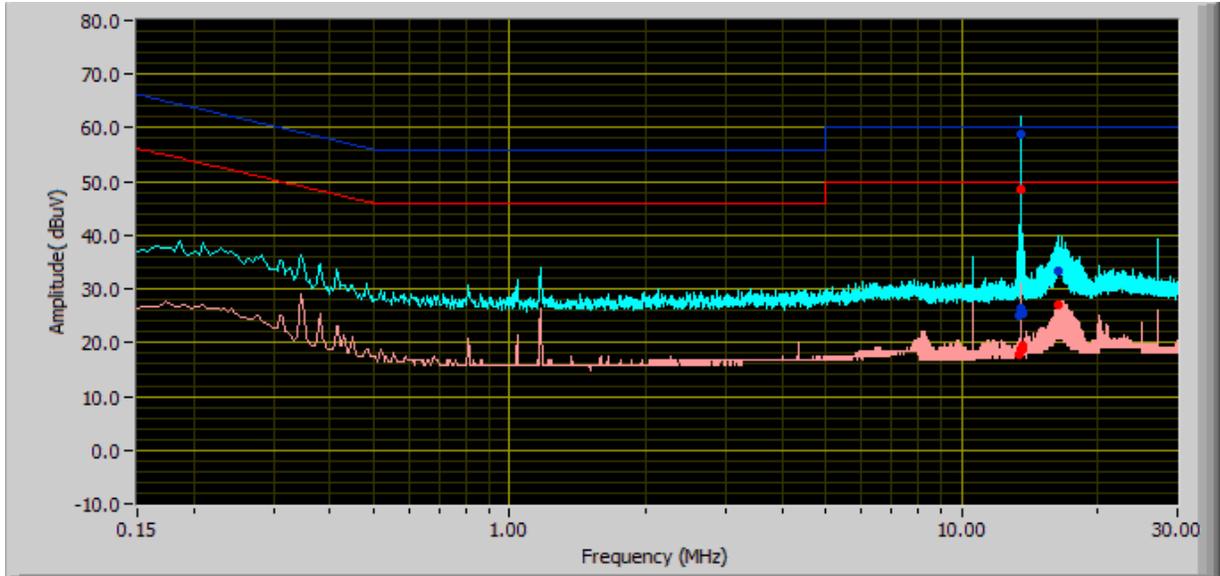


Quasi-Peak Limit

Average Limit

**Phase Line Plot at 120Vac, 60Hz**

Frequency (MHz)	OP Value (dB $\mu$ V)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Avg Value (dB $\mu$ V)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Line
13.56	59.43	60.00	PASS	-0.57	49.09	50.00	PASS	-0.91	Phase
0.35	44.28	59.11	PASS	-14.83	41.47	49.11	PASS	-7.64	Phase
13.49	27.98	60.00	PASS	-32.02	18.68	50.00	PASS	-31.32	Phase
13.64	27.49	60.00	PASS	-32.51	19.40	50.00	PASS	-30.60	Phase
16.56	38.24	60.00	PASS	-21.76	32.06	50.00	PASS	-17.94	Phase
16.76	37.35	60.00	PASS	-22.65	31.24	50.00	PASS	-18.76	Phase



Quasi-Peak Limit

Average Limit

**Neutral Line Plot at 120Vac, 60Hz**

Frequency (MHz)	QP Value (dBμV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Avg Value (dBμV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Line
13.56	59.43	60.00	PASS	-0.88	48.43	50.00	PASS	-1.57	Neutral
0.35	44.28	59.11	PASS	-33.65	18.68	50.00	PASS	-31.32	Neutral
13.49	27.98	60.00	PASS	-34.95	17.92	50.00	PASS	-32.08	Neutral
13.64	27.49	60.00	PASS	-34.25	18.70	50.00	PASS	-31.30	Neutral
16.56	38.24	60.00	PASS	-26.76	27.08	50.00	PASS	-22.92	Neutral
16.76	37.35	60.00	PASS	-34.57	19.40	50.00	PASS	-30.60	Neutral

### 5.3 Radiated Emission < 30MHz (9kHz - 30MHz, H-Field)

**Requirement(s):** 47 CFR §15.225 & RSS-210 (A2.6) & RSS-310 (3.7)

**Procedures:** For < 30MHz, Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output power. The EUT was set 10 meter away from the measuring antenna. The loop antenna was positioned 1 meter above the ground from the centre of the loop. The measuring bandwidth was set to 10 kHz. (Note: During testing the receive antenna was rotated about its axis to maximize the emission from the EUT.)

The limit is converted from microvolt/meter to decibel microvolt/meter.

**Sample Calculation:** Corrected Amplitude = Raw Amplitude (dB $\mu$ V/m) + ACF (dB) + Cable Loss(dB) – Distance Correction Factor

**Results:** Pass

**(Frequency: 125 kHz)**

Loop Antenna Positioned at 0 degrees, Azimuth 0 degrees with RFID activated

Frequency	Raw Amplitude @ 3m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 300m	Limits @ 300m	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
0.125	19.4	Peak	1.00	66.9	0	28.4	80	-22.10	25.67	-47.77

**Table 1**

Loop Antenna Positioned at 90 degrees, Azimuth 90 degrees with RFID activated

Frequency	Raw Amplitude @ 3m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 300m	Limits @ 300m	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
0.125	18.3	Peak	1.00	66.9	0	28.4	80	-23.20	25.67	-48.87

**Table 2**

**(Frequency: 13.56 MHz)**

Loop Antenna Positioned at 0 degrees, Azimuth 0 degrees with RFID activated

Frequency	Raw Amplitude @ 10m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 30m	Limits Part 15.209 & Part 15.225	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
13.56	40.80	Peak	2.00	35.40	0.30	27.20	20.92	17.92	84.00	-66.08
27.12	15.50	Peak	1.50	34.20	0.30	27.20	20.92	-8.58	29.54	-38.12

**Table 3**

Loop Antenna Positioned at 90 degrees, Azimuth 90 degrees with RFID activated

Frequency	Raw Amplitude @ 10m	Measure	Ant. Height	Ant. Factor	Cable Loss	Pre Amp Gain	Distance Correction Factor	Corrected Amplitude @ 30m	Limits Part 15.209 & Part 15.225	Margin
(MHz)	(dBµV/m)	(Avg/QP)	(m)	(dB)	(dB)	(dBm)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
13.56	46.30	Peak	2.00	35.40	0.30	27.20	20.92	23.42	84.00	-60.58
27.12	16.30	Peak	1.00	34.20	0.30	27.20	20.92	-7.78	29.54	-37.32

**Table 4**

## **5.4 Radiated Emissions > 30 MHz (30MHz - 1 GHz, E-Field)**

**Requirement(s):** 47 CFR §15.209; 47 CFR §15.225(d) & RSS-210 (A2.6)

**Procedures:** For > 30MHz, Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output power. The EUT was set 10 meter away from the measuring antenna. The Log periodic antenna was positioned 1 meter above the ground from the centre of the antenna. The measuring bandwidth was set to 120 kHz. (Note: During testing the receive antenna was raise from 1~4 meters to maximize the emission from the EUT.)

The limit is converted from microvolt/meter to decibel microvolt/meter.

Sample Calculation: Corrected Amplitude = Raw Amplitude (dBμV/m) + ACF (dB) + Cable Loss(dB) – Distance Correction Factor

**Results:** Pass

Frequency	Raw Amplitude @ 10m (QP)	Azimuth	Ant. Height	Ant. Polarity	Ant. Factor	Cable Loss	Pre Amp Gain	Corrected Amplitude @ 10m	Limit @10m	Margin
(MHz)	(dBµV/m)	(Degrees)	(m)	(H/V)	(dB)	(dB)	(dBm)	(dBµV/m)	(dBµV/m)	(dBµV/m)
40.68	26.80	180.00	2.50	H	12.63	0.30	27.10	12.63	29.54	-16.91
40.68	31.30	295.00	1.00	V	12.63	0.30	27.10	17.13	29.54	-12.41
54.24	35.80	270.00	2.40	H	7.20	0.50	26.70	16.80	29.54	-12.74
54.24	40.10	0.00	1.00	V	7.20	0.50	26.70	21.10	29.54	-8.44
284.76	33.50	194.00	2.60	H	13.51	1.40	26.60	21.81	35.54	-13.73
284.76	31.60	67.00	1.00	V	13.51	1.40	26.60	19.91	35.54	-15.63
406.81	36.90	40.00	2.60	H	16.04	2.10	26.60	28.44	35.54	-7.11
406.81	31.50	210.00	1.00	V	16.04	2.10	26.60	23.04	35.54	-12.51
393.24	31.70	125.00	3.30	H	15.63	1.70	26.60	22.43	35.54	-13.11
393.24	27.70	256.00	1.00	V	15.63	1.70	26.60	18.43	35.54	-17.11
379.69	33.80	217.00	2.40	H	15.51	1.70	26.60	24.41	35.54	-11.13
379.69	31.60	229.00	1.00	V	15.51	1.70	26.60	22.21	35.54	-13.33
366.12	35.50	211.00	3.50	H	15.42	1.70	26.60	26.02	35.54	-9.52
366.12	30.10	31.00	1.00	V	15.42	1.70	26.60	20.62	35.54	-14.92
474.60	33.80	180.00	1.00	H	17.48	2.10	26.60	26.78	35.54	-8.76
474.60	32.60	70.00	1.00	V	17.48	2.10	26.60	25.58	35.54	-9.96
149.16	29.90	263.00	3.20	H	13.50	1.00	26.60	17.80	33.04	-15.24
149.16	31.60	156.00	1.00	V	13.50	1.00	26.60	19.50	33.04	-13.54
339.00	29.90	49.00	3.00	H	14.48	1.70	26.60	19.48	35.54	-16.06
339.00	28.70	125.00	1.00	V	14.48	1.70	26.60	18.28	35.54	-17.26
488.17	31.60	321.00	1.90	H	17.76	2.10	26.60	24.86	35.54	-10.68
488.17	31.80	202.00	1.00	V	17.76	2.10	26.60	25.06	35.54	-10.48
257.65	36.80	250.00	4.00	H	12.80	1.40	26.60	24.40	35.54	-11.14
257.65	31.60	246.00	1.00	V	12.80	1.40	26.60	19.20	35.54	-16.34
515.30	31.60	0.00	1.00	H	17.80	2.10	26.60	24.90	35.54	-10.64
515.30	30.80	210.00	1.00	V	17.80	2.10	26.60	24.10	35.54	-11.44
542.42	36.40	180.00	1.00	H	18.15	2.10	26.60	30.05	35.54	-5.49
542.42	36.30	204.00	1.00	V	18.15	2.10	26.60	29.95	35.54	-5.59
528.86	33.70	180.00	1.00	H	17.80	2.10	26.60	27.00	35.54	-8.54
528.86	32.70	203.00	1.00	V	17.80	2.10	26.60	26.00	35.54	-9.54

**Table 5**

## 5.5 Frequency Stability

**Requirement(s):** 47 CFR §15.225(e) & RSS-210 (A2.6)

**Procedures:** Frequency Stability was measured according to 47 CFR §2.1055. Measurement was taken with spectrum analyzer. The spectrum analyzer bandwidth and span was set to read in hertz. A voltmeter was used to monitor when varying the voltage.

Limit:  $\pm 0.01\%$  of 13.56 MHz = 1356 Hz,  $\pm 0.01\%$  of 125 kHz = 125 Hz

**Results:** Pass

**NOTE:** Applicant stated that the MultiCLASS Model: RP40N-6408-300 was tested as the representative sample for the following reasons:

- 1) The 13.56 MHz RF section is electrically identical in all iCLASS and MultiCLASS Models accept for antenna size which has no bearing on this requirement
- 2) The 125 kHz RF Transmit section is schematically identical in all MultiCLASS Models. The minor change in layout has no bearing on this requirement

Given this Model: RP40N-6408-300 was tested as the representative Model for all iCLASS and MultiCLASS Models

**Frequency Stability versus Temperature:** The Frequency tolerance of the carrier signal shall be maintained within  $\pm 0.01\%$  of the operating frequency over a temperature variation of -20°C to +50°C at normal supply voltage.

Reference Frequency: 125.025 kHz at -20°C and +50°C

Temperature (°C)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
50	125.033	8.0	<0.01	Pass
20	Reference			
-20	125.048	23	<0.01	Pass

**Table 6**

**Note:** The EUT met the applicable requirement throughout the temperature range. Only the extremes are reported

**Frequency Stability versus Input Voltage:** The Frequency tolerance of the carrier signal shall be maintained within  $\pm 0.01\%$ , the frequency of the transmitter was measured at 85% and at 115% of the rated power supply voltage at 20°C environmental temperature.

Carrier Frequency: 125.025 kHz at 20°C at 12VDC

Measured Voltage $\pm 15\%$ of nominal (DC)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
10.2	125.028	3.0	<0.01	Pass
13.8	125.030	5.0	<0.01	Pass

**Table 7**

**Frequency Stability versus Temperature:** The Frequency tolerance of the carrier signal shall be maintained within  $\pm 0.01\%$  of the operating frequency over a temperature variation of  $-20^{\circ}\text{C}$  to  $+50^{\circ}\text{C}$  at normal supply voltage.

Reference Frequency: 13.56037 MHz at  $-20^{\circ}\text{C}$  and  $+50^{\circ}\text{C}$

Temperature (°C)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
50	13.56048	110	<0.01	Pass
40	13.56052	150	<0.01	Pass
30	13.56068	310	<0.01	Pass
20	Reference			
10	13.56086	490	<0.01	Pass
0	13.56086	490	<0.01	Pass
-10	13.56093	560	<0.01	Pass
-20	13.56096	590	<0.01	Pass

**Table 8**

**Frequency Stability versus Input Voltage:** The Frequency tolerance of the carrier signal shall be maintained within  $\pm 0.01\%$ , the frequency of the transmitter was measured at 85% and at 115% of the rated power supply voltage at  $20^{\circ}\text{C}$  environmental temperature.

Carrier Frequency: 13.56037 MHz at  $20^{\circ}\text{C}$  at 12VDC

Measured Voltage $\pm 15\%$ of nominal (DC)	Measured Freq. (MHz)	Freq. Drift (Hz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
10.2	13.56038	10	<0.01	Pass
13.8	13.56040	30	<0.01	Pass

**Table 9**

## **5.6 Occupied Bandwidth**

**Requirement(s):** RSS-210 (5.9.1)

**Procedures:** Occupied Bandwidth was measured according to RSS-210 (5.9.1). Measurement was taken with spectrum analyzer. The spectrum analyzer bandwidth and span was set to read in hertz.

**Results:** Pass

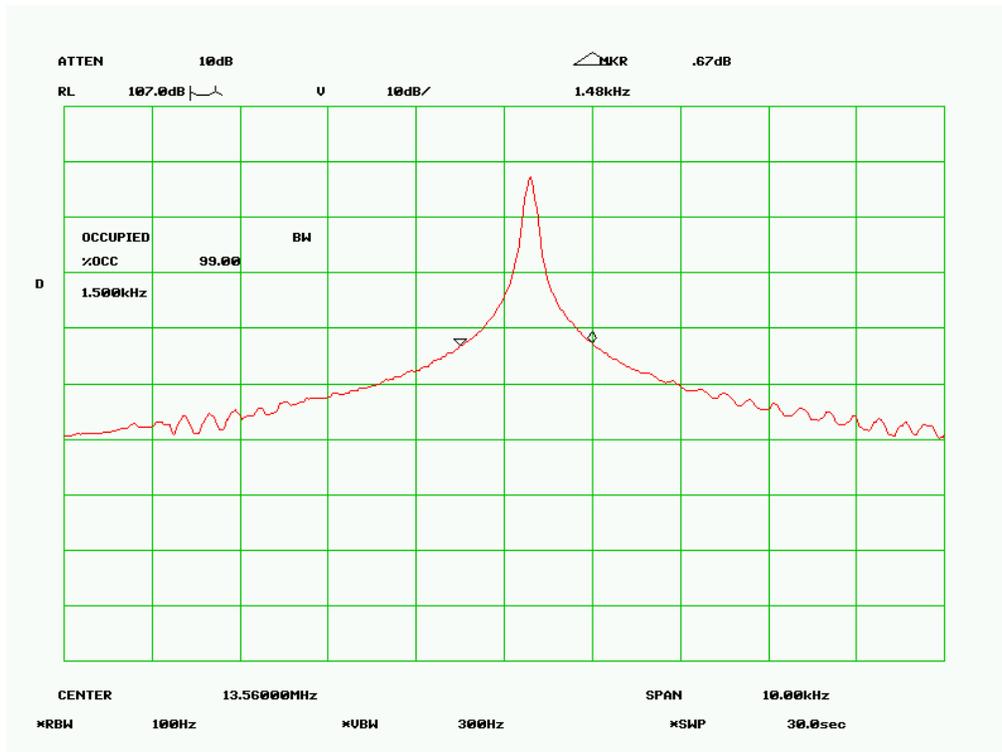
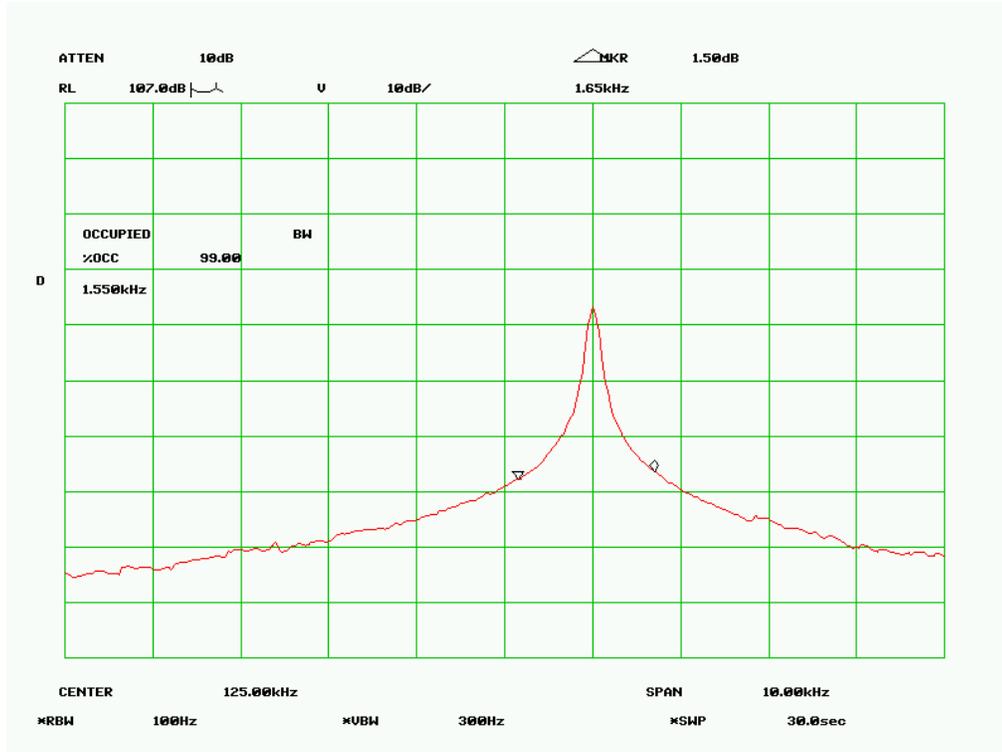
**NOTE:** Applicant stated that the MultiCLASS Model: RP40N-6408-300 was tested as the representative sample for the following reasons:

- 1) The 13.56 MHz RF section is electrically identical in all iCLASS and MultiCLASS Models except for antenna size which has no bearing on this requirement
- 2) The 125 kHz RF Transmit section is schematically identical in all MultiCLASS Models. The minor change in layout has no bearing on this requirement

Given this Model: RP40N-6408-300 was tested as the representative Model for all iCLASS and MultiCLASS Models



### Plots: 125 kHz



### Plots: 13.56 MHz

## Annex A. TEST INSTRUMENT & METHOD

### Annex A.i. TEST INSTRUMENTATION & GENERAL PROCEDURES

Instrument	Model	Serial #	Calibration Due
<b>Conducted Emissions</b>			
R & S Receiver	ESIB 40	100179	04/25/2009
R&S LISN	ESH2-Z5	861741/013	04/27/2009
CHASE LISN	MN2050B	1018	04/26/2009
<b>Radiated Emissions</b>			
R & S Receiver	ESIB 40	100179	04/25/2009
Sunol Sciences, Inc. antenna (30MHz-2GHz)	JB1	A030702	01/04/2009
ETS-Lingren Loop Antenna	6512	00049120	05/13/2009
DMM	Fluke	73III	05/01/2009
Variac	KRM	AEEC-2090	See Note
Environment Chamber	Test Equity	1007H	01/24/2009

Note: Functional Verification

**Annex A.ii. CONDUCTED EMISSIONS TEST DESCRIPTION**

**Test Set-up**

1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table, as shown in Annex B.
2. The power supply for the EUT was fed through a 50Ω/50μH EUT LISN, connected to filtered mains.
3. The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable.
4. All other supporting equipments were powered separately from another main supply.

**Test Method**

1. The EUT was switched on and allowed to warm up to its normal operating condition.
2. A scan was made on the NEUTRAL line (for AC mains) or Earth line (for DC power) over the required frequency range using an EMI test receiver.
3. High peaks, relative to the limit line, were then selected.
4. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10 KHz. For FCC tests, only Quasi-peak measurements were made; while for CISPR/EN tests, both Quasi-peak and Average measurements were made.
5. Steps 2 to 4 were then repeated for the LIVE line (for AC mains) or DC line (for DC power).

**Sample Calculation Example**

At 20 MHz	limit = 250 μV = 47.96 dBμV
Transducer factor of LISN, pulse limiter & cable loss at 20 MHz = 11.20 dB	
Q-P reading obtained directly from EMI Receiver = 40.00 dBμV (Calibrated for system losses)	
Therefore, Q-P margin = 47.96 – 40.00 = 7.96	i.e. <b>7.96 dB below limit</b>

## Annex A. iii RADIATED EMISSIONS TEST DESCRIPTION

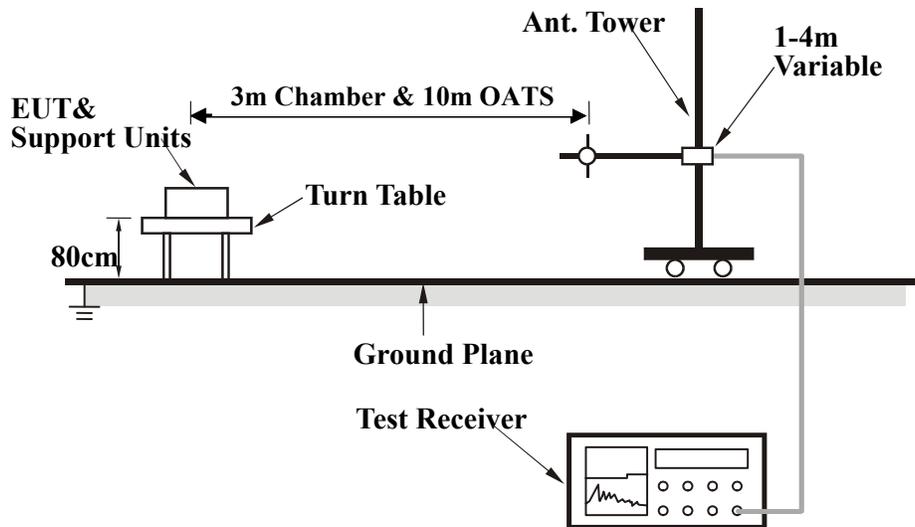
### EUT Characterisation

EUT characterisation, over the frequency range from 100kHz – 1GHz to 10<sup>th</sup> Harmonic , was done in order to minimise radiated emissions testing time while still maintaining high confidence in the test results.

The EUT was placed in the chamber, at a height of about 0.8m on a turntable. Its radiated emissions frequency profile was observed, using a spectrum analyzer /receiver with the appropriate broadband antenna placed 3m away from the EUT. Radiated emissions from the EUT were maximised by rotating the turntable manually, changing the antenna polarisation and manipulating the EUT cables while observing the frequency profile on the spectrum analyzer / receiver. Frequency points at which maximum emissions occurred: clock frequencies and operating frequencies were then noted for the formal radiated emissions test at the Open Area Test Site (OATS) at 10m distance.

### Test Set-up

1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m X 1.0m X 0.8m high, non-metallic table.
2. The filtered power supply for the EUT and supporting equipment were tapped from the appropriate power sockets located on the turntable.
3. The relevant broadband antenna was set at the required test distance away from the EUT and supporting equipment boundary.



**Test Method**

The following procedure was performed to determine the maximum emission axis of EUT:

1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

**Final Radiated Emission Measurement**

1. Setup the configuration according to figure 1. Turn on EUT and make sure that it is in normal function.
2. For emission frequencies measured below 1 GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on a open test site. As the same purpose, for emission frequencies measured above 1 GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.
3. For emission frequencies measured below 1 GHz, set the spectrum analyzer on a 100 kHz and 1 MHz resolution bandwidth respectively for each frequency measured in step 2.
4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from 0 ° to 360 ° with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading.
5. Repeat step 4 until all frequencies need to be measured were complete.
6. Repeat step 5 with search antenna in vertical polarized orientations.

During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

Frequency Band (MHz)	Function	Resolution bandwidth	Video Bandwidth
30 to 1000	Peak	100 kHz	100 kHz
Above 1000	Peak	1 MHz	1 MHz
	Average	1 MHz	10 Hz

**Sample Calculation Example**

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. For the limit is employed average value, therefore the peak value can be transferred to average value by subtracting the duty factor. The basic equation with a sample calculation is as follows:

$$\text{Peak} = \text{Reading} + \text{Corrected Factor}$$

where

$$\text{Corr. Factor} = \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain (if any)}$$

And the average value is

$$\text{Average} = \text{Peak Value} + \text{Duty Factor or}$$

$$\text{Set RBW} = 1\text{MHz, VBW} = 10\text{Hz.}$$

Note :

If the measured frequencies are fall in the restricted frequency band, the limit employed must be quasi peak value when frequencies are below or equal to 1 GHz. And the measuring instrument is set to quasi peak detector function.

**Annex B. TEST SETUP PHOTOGRAPHS**



AC Line Conducted Emission Test Setup – Front View (RP40)



Radiated Emission Test Setup – Front View (<30MHz)



Radiated Emission Test Setup – Rear View (<30MHz)



Radiated Emission Test Setup – Front View (>30MHz)

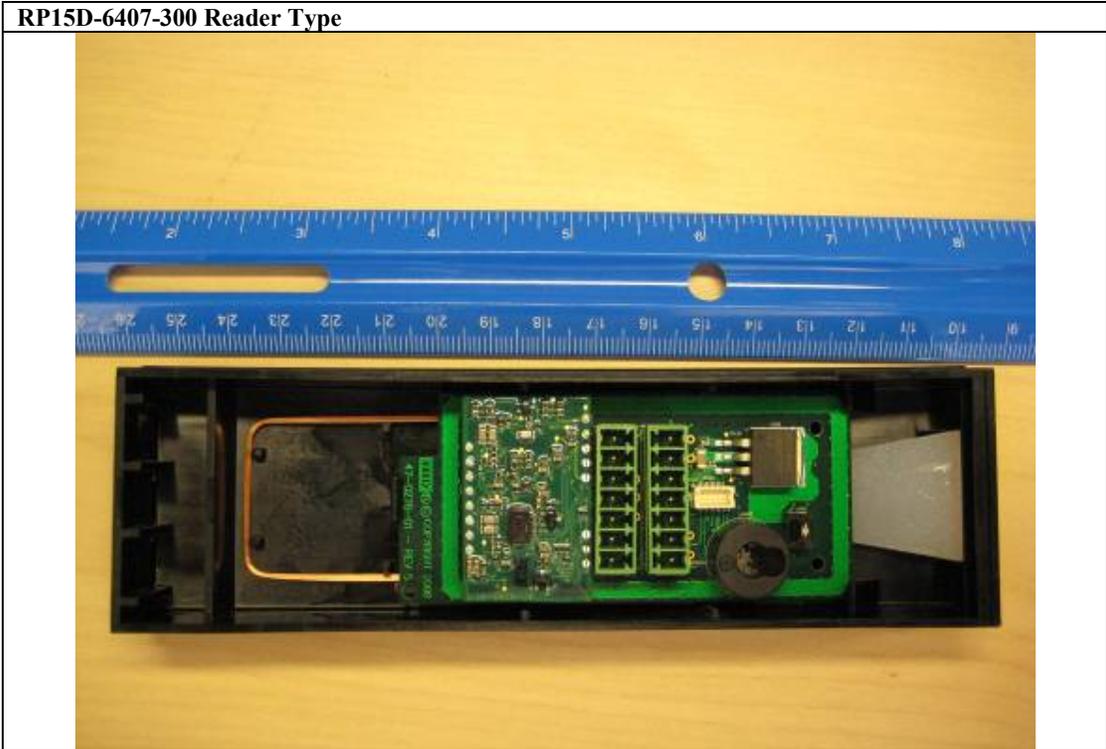


Radiated Emission Test Setup – Rear View (>30MHz)

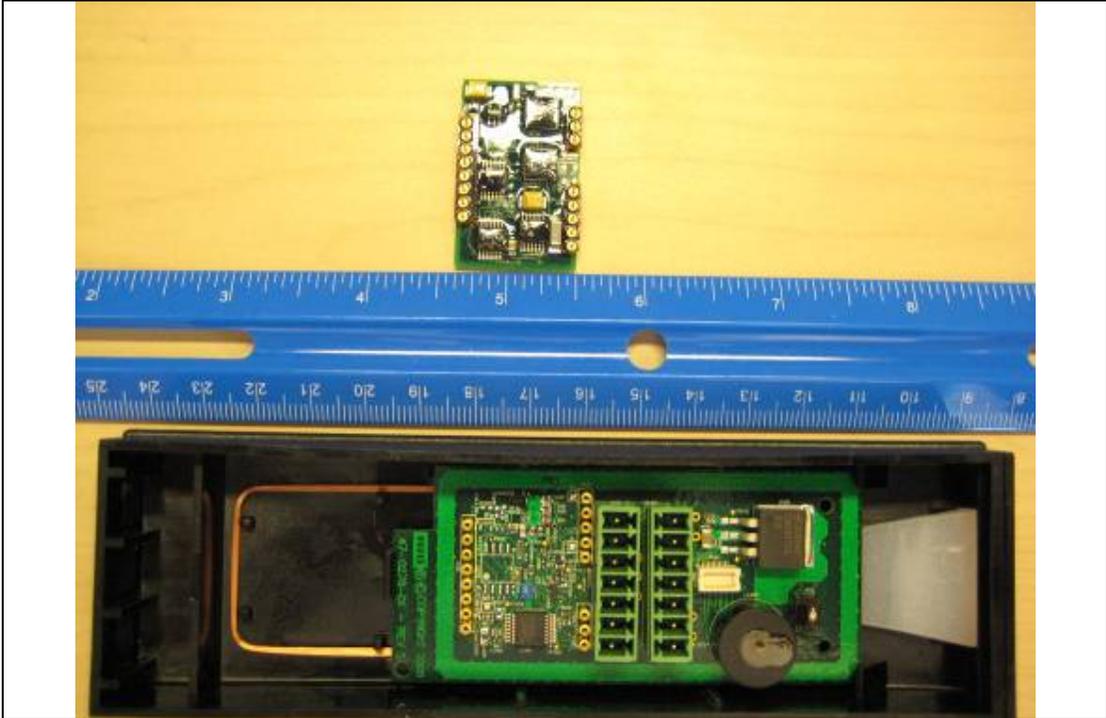


Frequency Stability and Occupied Bandwidth Test Setup – Front View (RP40)

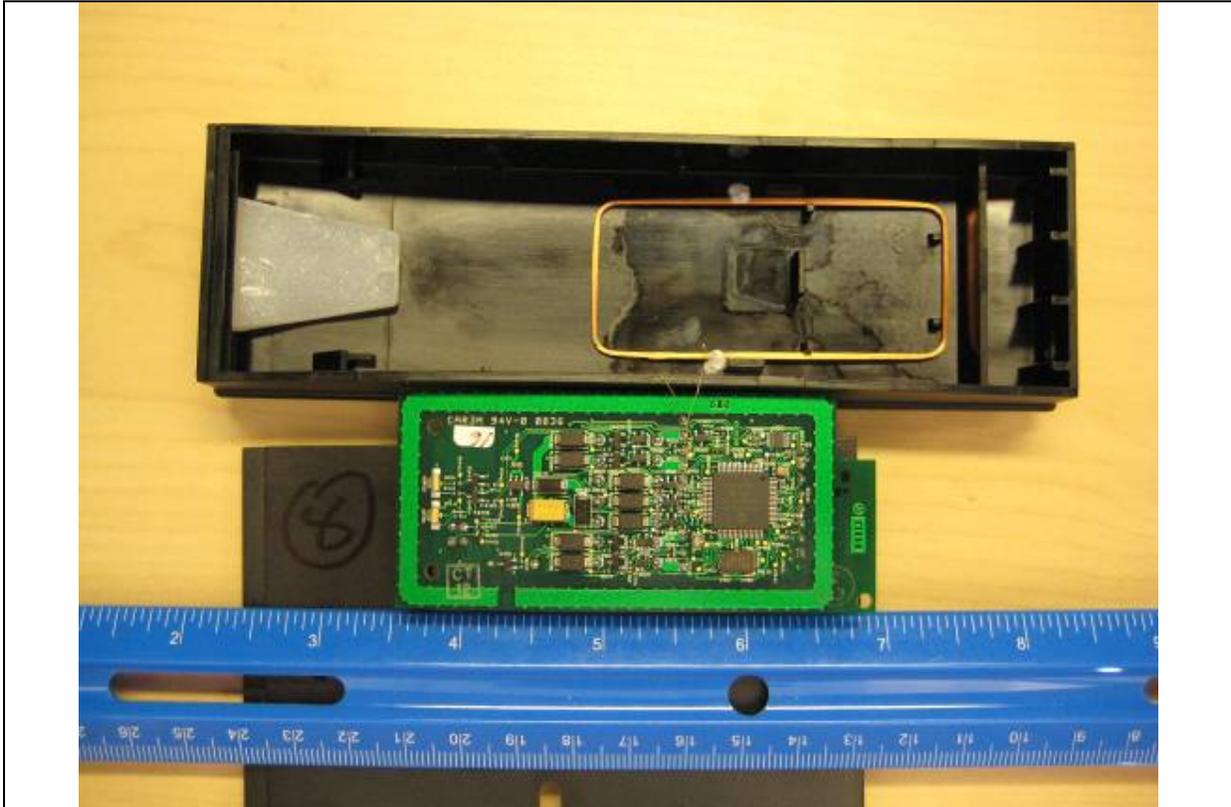
**Annex B. i. EUT INTERNAL PHOTOGRAPHS**



Reader Board in Plastic Housing with Digital I/O Board – Not Potted



Reader Board in Plastic Housing without Digital I/O Board – Not Potted



Reader Board in Plastic Housing with Antenna – Not Potted



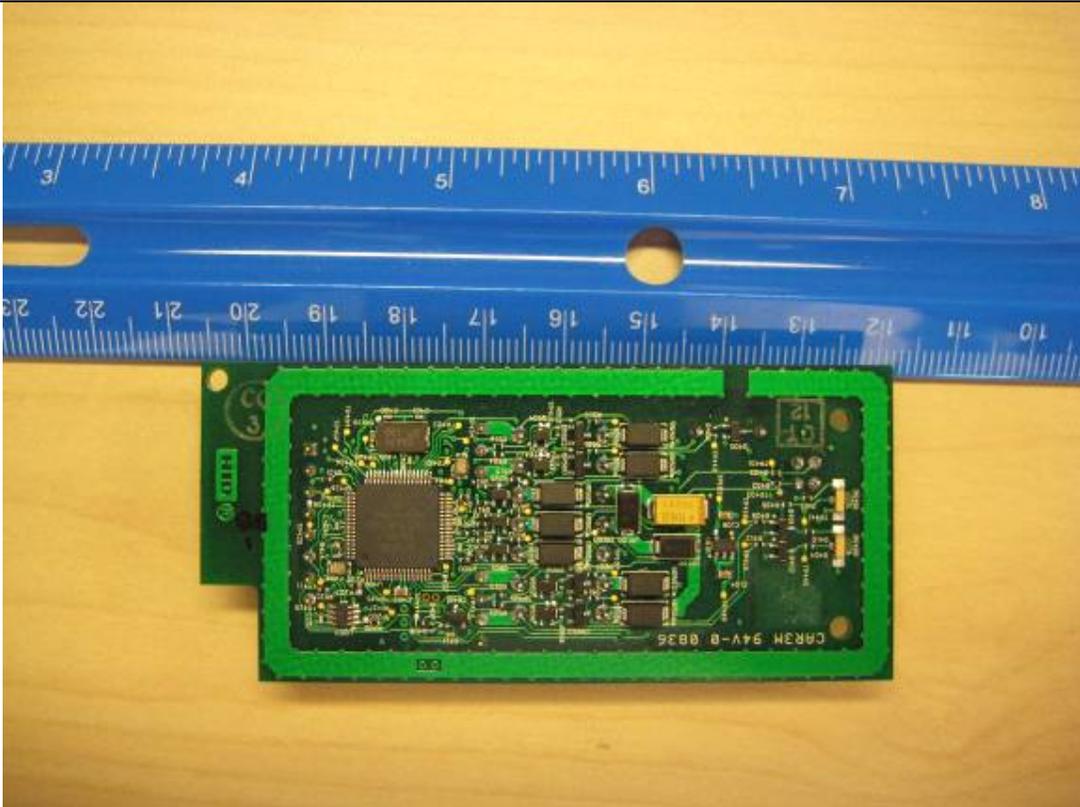
Antenna in Plastic Housing after Reader Board Removed



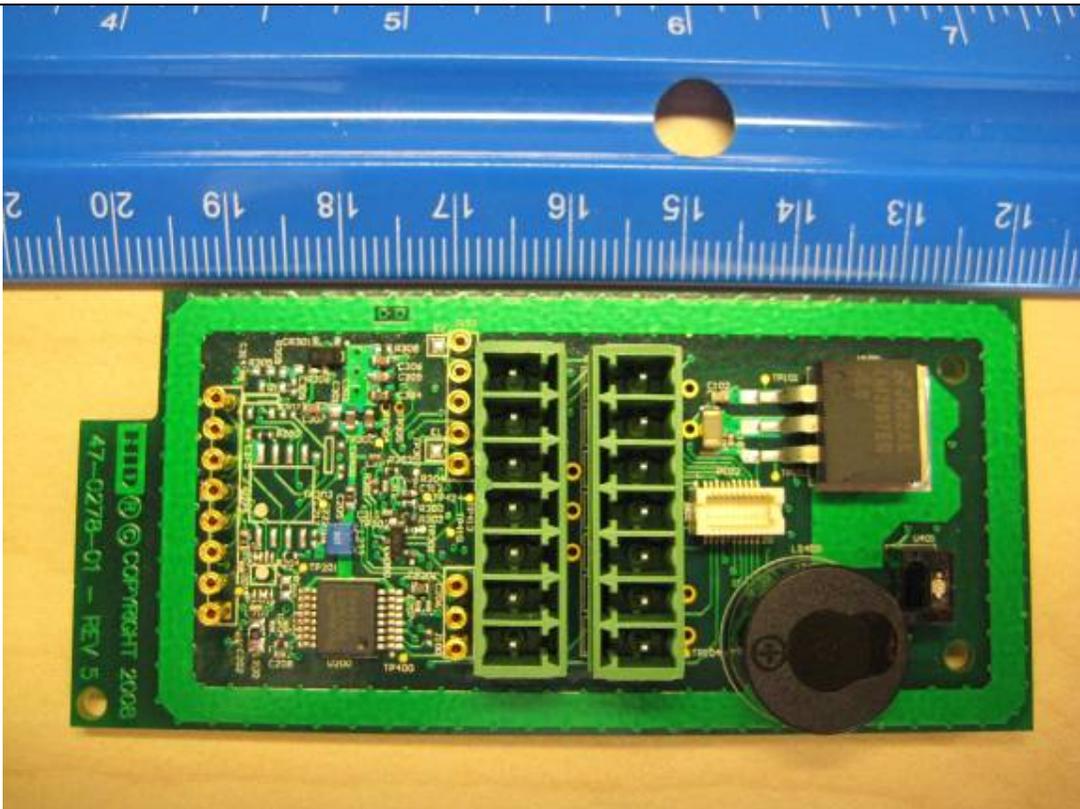
Plastic Housing after Reader Board Removed



Reader Board in Plastic Housing – Potted

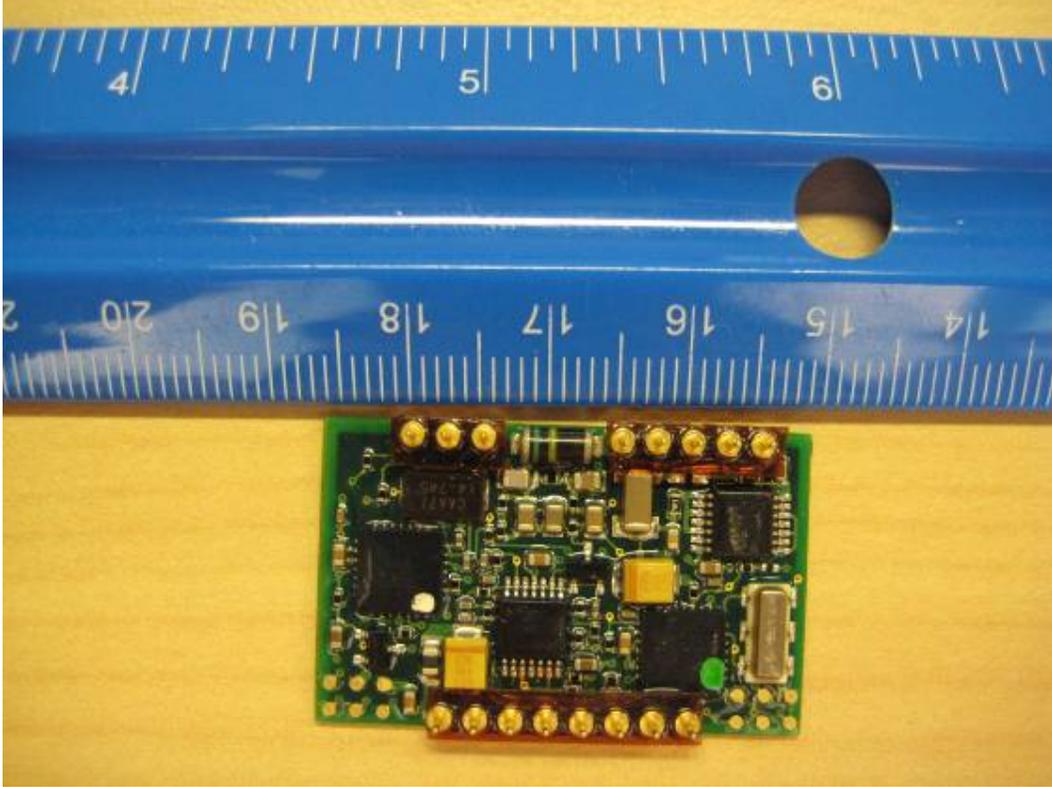


Front side of Reader Board

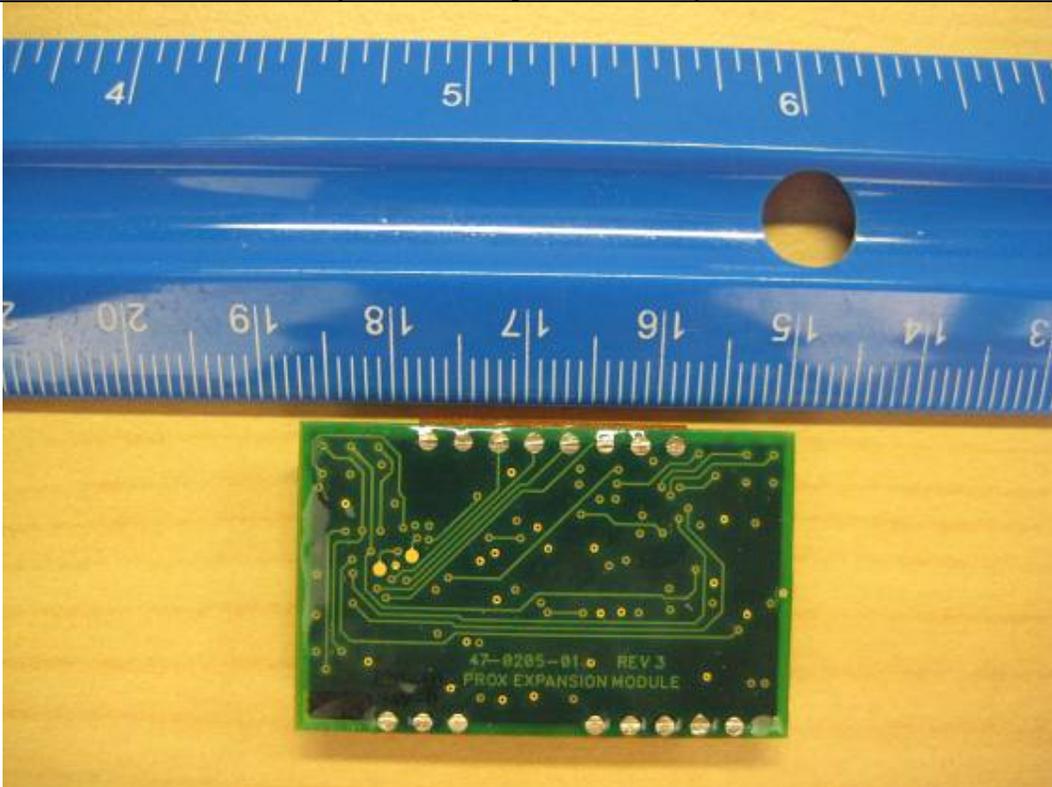


Back side of reader board with RF Section

**General Reader Section – Showing Optional Digital I/O board mounted on an RP15D-6407-300 PWB – mounts on board covering the RF section on each reader type.**

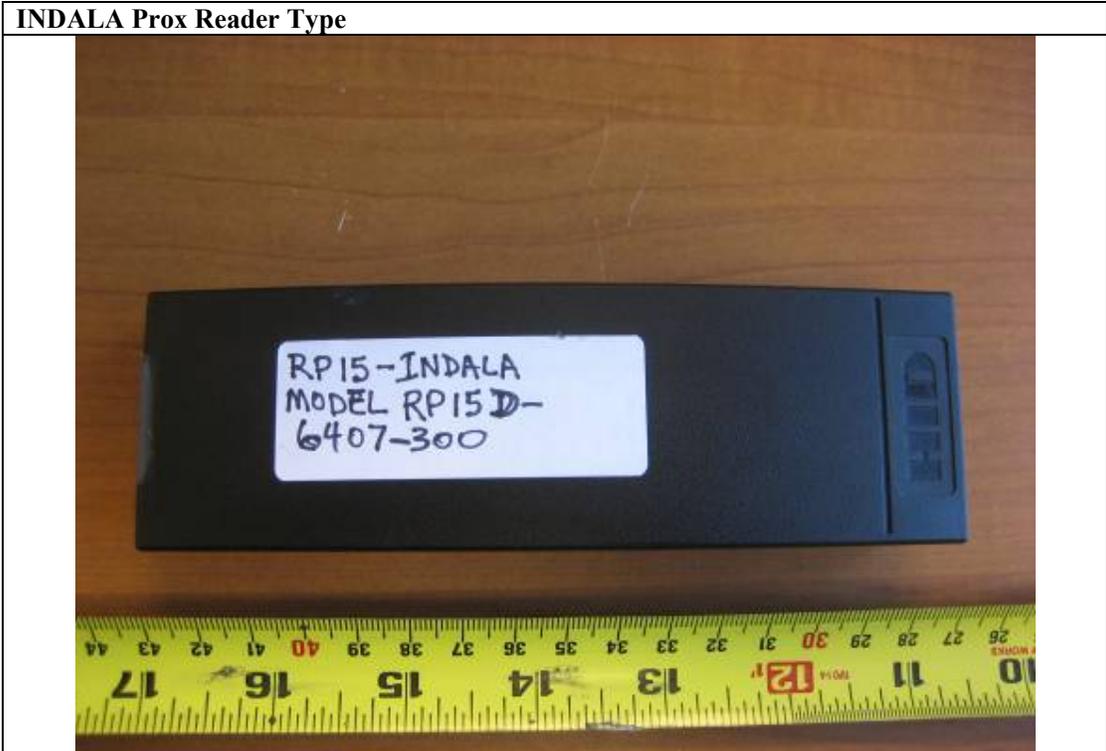


Component side of Digital I/O Board (Optional)



Solder side of Digital I/O Board (Optional)

**Annex B. ii. EUT EXTERNAL PHOTOGRAPHS**



Top View



Bottom View



Right View



Side View



Front View



Rear View

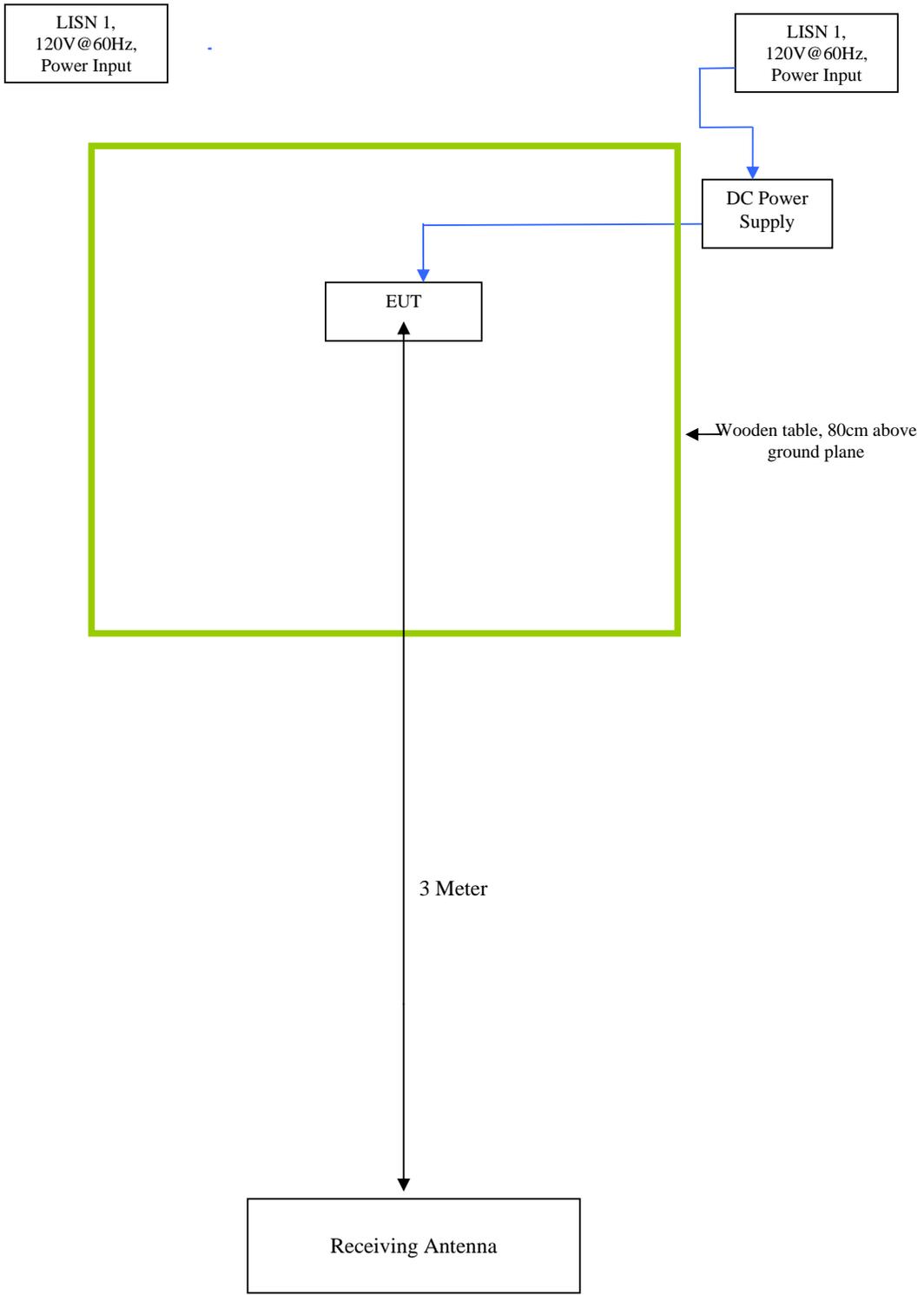
**Annex C. SUPPORTING EQUIPMENT DESCRIPTION**

The following is a description of supporting equipment and details of cables used with the EUT.

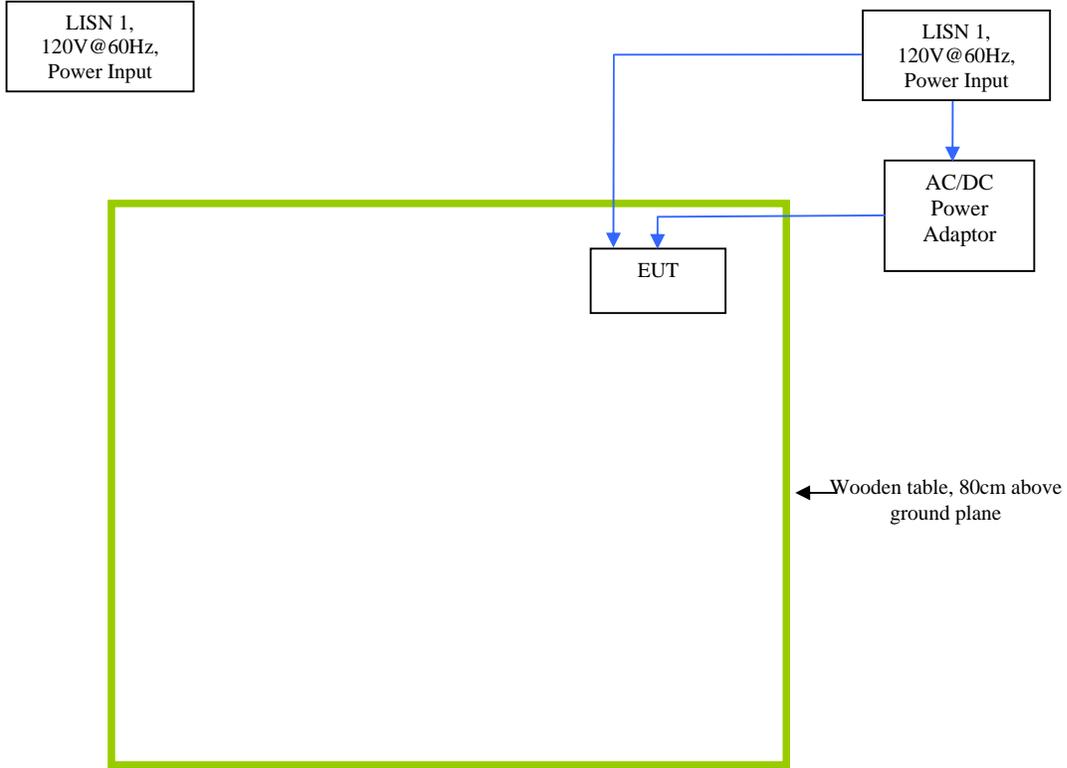
Equipment Description (Including Brand Name)	Model & Serial Number	Cable Description (List Length, Type & Purpose)
Topward Electric Instrument Co., Ltd. Linear AC/DC Power Supply	Model: TPS-2000 SN: 920035	N/A

**NOTE:** No special supporting equipment are used or needed during testing to achieve compliance.

### Block Configuration Diagram for Radiated Emission



### Block Configuration Diagram for Conducted Emission



**Annex C. EUT OPERATING CONDITIONS**

The following is the description of how the EUT is exercised during testing.

<b>Test</b>	<b>Description Of Operation</b>
<b>Emissions Testing</b>	The EUT was controlled by itself.
<b>Others Testing</b>	The EUT was controlled by itself.

## **Annex D USER MANUAL, BLOCK & CIRCUIT DIAGRAM**

**Please see attachment**